



**THE DATASHEET OF
NCP5210MNR2G**



NCP5210

3-in-1 PWM Dual Buck and Linear DDR Power Controller

The NCP5210, 3-in-1 PWM Dual Buck and Linear DDR Power Controller, is a complete power solution for MCH and DDR memory. This IC combines the efficiency of PWM controllers for the VDDQ supply and the MCH core supply voltage with the simplicity of linear regulator for the VTT termination voltage.

This IC contains two synchronous PWM buck controller for driving four external N-Ch FETs to form the DDR memory supply voltage (VDDQ) and the MCH regulator. The DDR memory termination regulator (VTT) is designed to track at the half of the reference voltage with sourcing and sinking current.

Protective features include, soft-start circuitry, undervoltage monitoring of 5VDUAL and BOOT voltage, and thermal shutdown. The device is housed in a thermal enhanced space-saving QFN-20 package.

Features

- Incorporates Synchronous PWM Buck Controllers for VDDQ and VMCH
- Integrated Power FETs with VTT Regulator Source/Sink up to 2.0 A
- All External Power MOSFETs are N-Channel
- Adjustable VDDQ and VMCH by External Dividers
- VTT Tracks at Half the Reference Voltage
- Fixed Switching Frequency of 250 kHz for VDDQ and VMCH
- Doubled Switching Frequency of 500 kHz for VDDQ Controller in Standby Mode to Optimize Inductor Current Ripple and Efficiency
- Soft-Start Protection for all Controllers
- Undervoltage Monitor of Supply Voltages
- Overcurrent Protections for DDQ and VTT Regulators
- Fully Complies with ACPI Power Sequencing Specifications
- Short Circuit Protection Prevents Damage to Power Supply Due to Reverse DIMM Insertion
- Thermal Shutdown
- 5x6 QFN-20 Package
- Pb-Free Package is Available*

Applications

- DDR I and DDR II Memory and MCH Power Supply

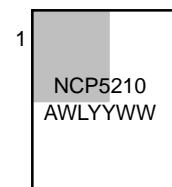
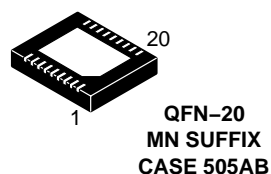
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



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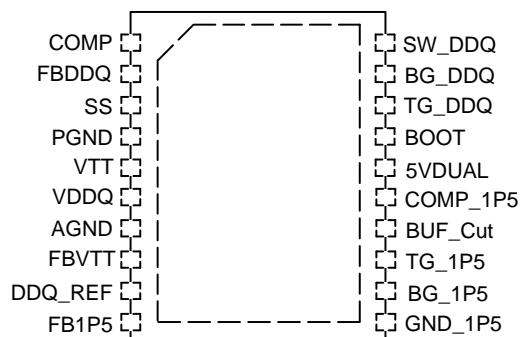
<http://onsemi.com>

MARKING DIAGRAM



NCP5210 = Specific Device Code
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week

PIN CONNECTIONS



NOTE: Pin 21 is the thermal pad on the bottom of the device.

ORDERING INFORMATION

Device	Package	Shipping†
NCP5210MNR2	QFN-20	2500 Tape & Reel
NCP5210MNR2G	QFN-20 (Pb-Free)	2500 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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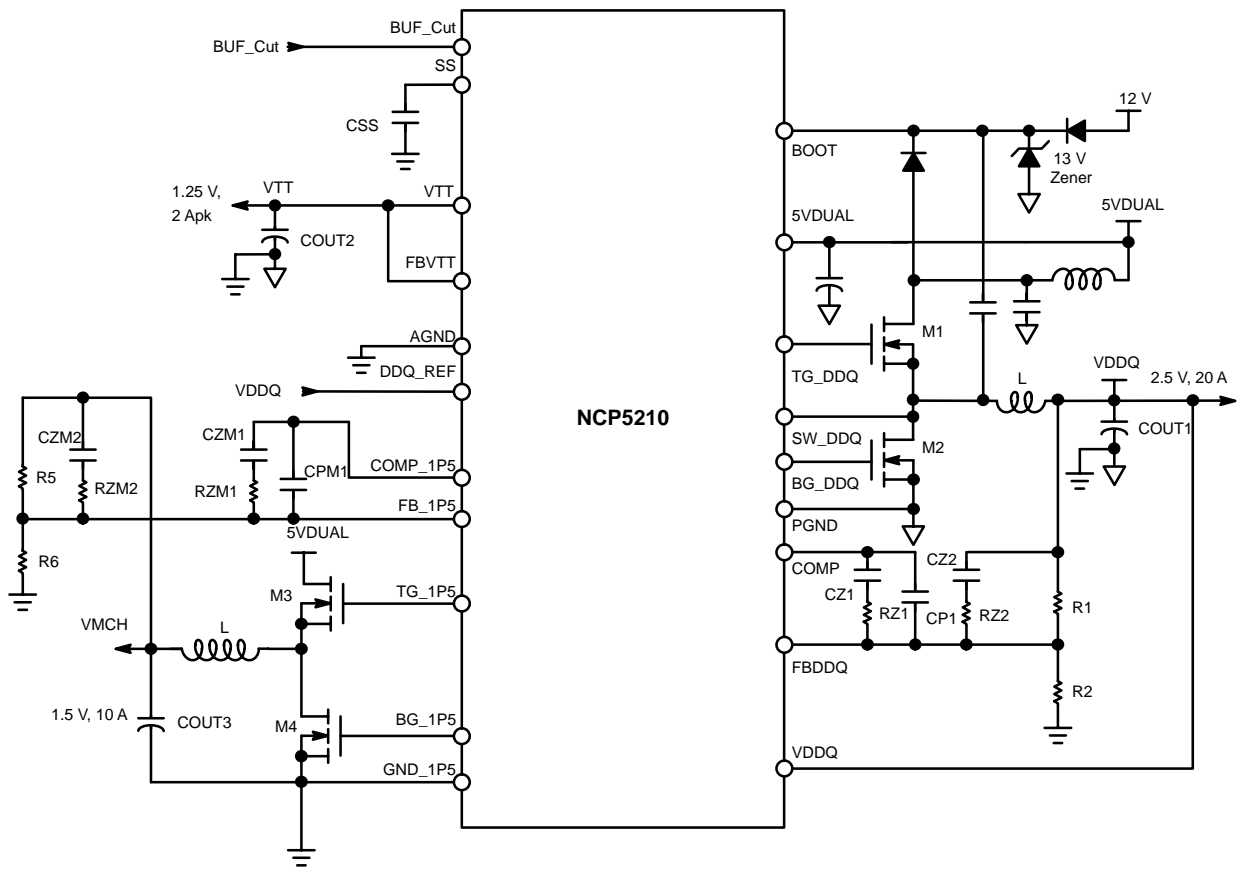


Figure 1. Application Diagram

NCP5210

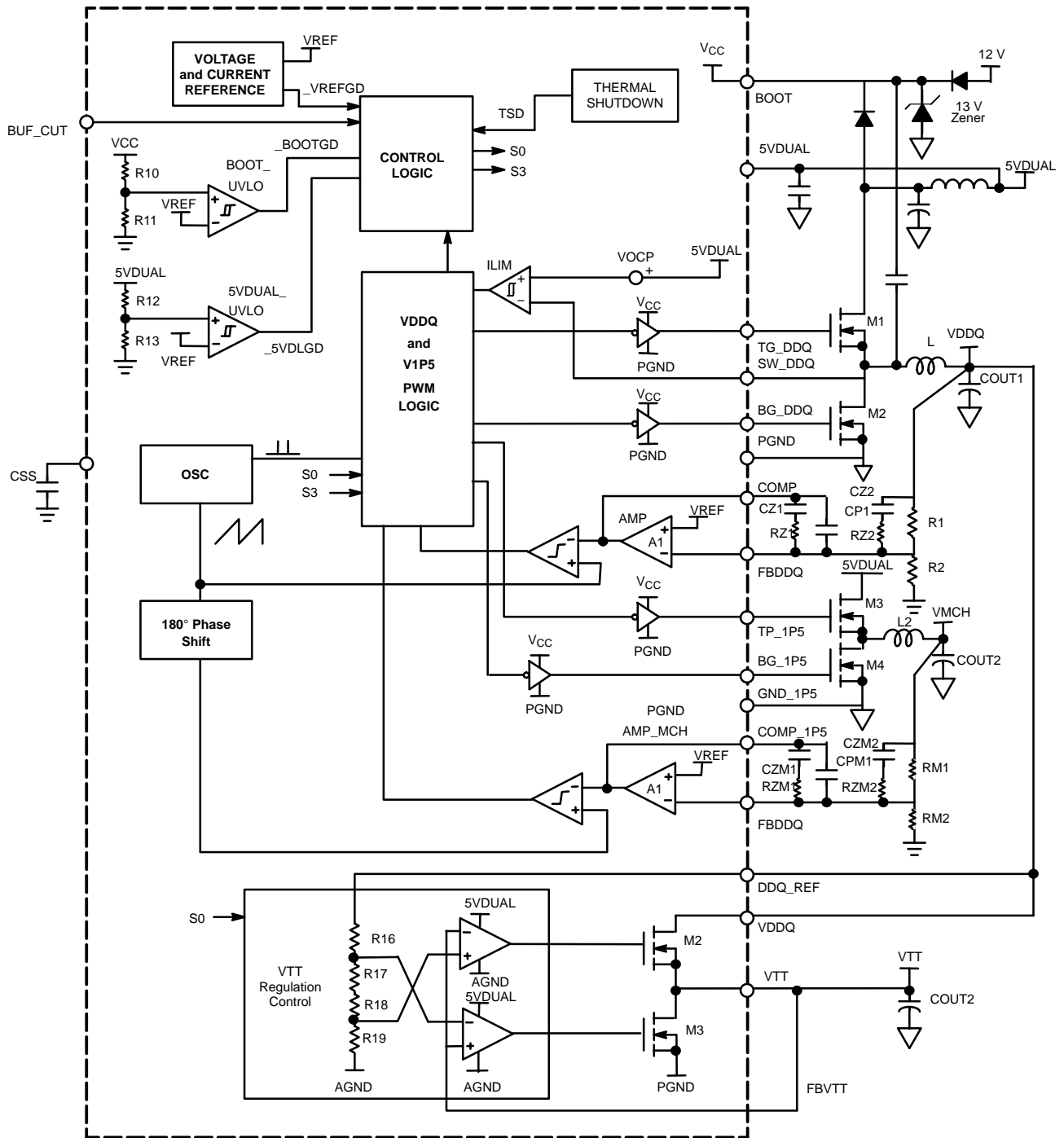


Figure 2. Internal Block Diagram

NCP5210

PIN DESCRIPTION

Pin	Symbol	Description
1	COMP	VDDQ error amplifier compensation node.
2	FBDDQ	DDQ regulator feedback pin.
3	SS	Soft-start pin of DDQ and MCH.
4	PGND	Power ground.
5	VTT	VTT regulator output.
6	VDDQ	Power input for VTT linear regulator.
7	AGND	Analog ground connection and remote ground sense.
8	FBVTT	VTT regulator pin for closed loop regulation.
9	DDQ_REF	Reference voltage input of VTT regulator.
10	FB1P5	V1P5 switching regulator feedback pin.
11	GND_1P5	Power ground for V1P5 regulator.
12	BG_1P5	Gate driver output for V1P5 regulator low side N-Channel Power FET.
13	TG_1P5	Gate driver output for V1P5 regulator high side N-Channel Power FET.
14	BUF_Cut	Active HIGH control signal to activate S3 sleep state.
15	COMP_1P5	V1P5 error amplifier compensation node.
16	5VDUAL	5.0 V Dual supply input, which is monitored by undervoltage lock out circuitry.
17	BOOT	Gate driver input supply, which is monitored by undervoltage lock out circuitry, and a boost capacitor connection between SWDDQ and this pin.
18	TG_DDQ	Gate driver output for DDQ regulator high side N-Channel Power FET.
19	BG_DDQ	Gate driver output for DDQ regulator low side N-Channel Power FET.
20	SW_DDQ	DDQ regulator switch node and current limit sense input.
21	TH_PAD	Copper pad on bottom of IC used for heatsinking. This pin should be connected to the ground plane under the IC.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Power Supply Voltage (Pin 16) to AGND (Pin 7)	5VDUAL	-0.3, 6.0	V
BOOT (Pin 17) to AGND (Pin 7)	BOOT	-0.3, 14	V
Gate Drive (Pins 12, 13, 18, 19) to AGND (Pin 7)	V _g	-0.3 DC, -4.0 for < 100 ns; 14	V
Input / Output Pins to AGND (Pin 7) Pins 1-3, 5-6, 8-10, 14-15, 20	V _{IO}	-0.3, 6.0	V
PGND (Pin 4), GND_1P5 (Pin 11) to AGND (Pin 7)	V _{GND}	-0.3, 0.3	V
Thermal Characteristics, QFN-20 Plastic Package Thermal Resistance Junction-to-Air	R _{θJA}	35	°C/W
Operating Junction Temperature Range	T _J	0 to + 150	°C
Operating Ambient Temperature Range	T _A	0 to + 70	°C
Storage Temperature Range	T _{stg}	- 55 to +150	°C
Moisture Sensitivity Level	MSL	2.0	

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

- This device series contains ESD protection and exceeds the following tests: Human Body Model (HBM) ±2.0 kV per JEDEC standard: JESD22-A114. Machine Model (MM) ±200 V per JEDEC standard: JESD22-A115.
- Latchup Current Maximum Rating: ±150 mA per JEDEC standard: JESD78.

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ELECTRICAL CHARACTERISTICS (5VDUAL = 5 V, BOOT = 12 V, 5VATX = 5 V, DDQ_REF = 2.5 V, $T_A = 0^\circ\text{C}$ to 70°C , $L = 1.7\ \mu\text{H}$, $\text{COUT1} = 3770\ \mu\text{F}$, $\text{COUT2} = 470\ \mu\text{F}$, $\text{COUT3} = \text{NA}$, $\text{CSS} = 33\ \text{nF}$, $\text{R1} = 2.166\ \text{k}\Omega$, $\text{R2} = 2\ \text{k}\Omega$, $\text{RZ1} = 20\ \text{k}\Omega$, $\text{RZ2} = 8\ \Omega$, $\text{CP1} = 10\ \text{nF}$, $\text{CZ1} = 6.8\ \text{nF}$, $\text{CZ2} = 100\ \text{nF}$, $\text{RM1} = 2.166\ \text{k}\Omega$, $\text{RM2} = 2\ \text{k}\Omega$, $\text{RZM1} = 20\ \text{k}\Omega$, $\text{RZM2} = 8\ \Omega$, $\text{CPM1} = 10\ \text{nF}$, $\text{CZM1} = 6.8\ \text{nF}$, $\text{CZM2} = 100\ \text{nF}$ for min/max values unless otherwise noted.) duplicate component values of MCH regulator from DDQ.

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
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SUPPLY VOLTAGE

5VDUAL Operating Voltage	V5VDUAL		4.5	5.0	5.5	V
BOOT Operating Voltage	VBOOT			12.0	13.2	V

SUPPLY CURRENT

S0 Mode Supply Current from 5VDUAL	I5VDL_S0	BUF_Cut = LOW, BOOT = 12 V, TG_1P5 and BG_1P5 Open			10	mA
S3 Mode Supply Current from 5VDUAL	I5VDL_S3	BUF_Cut = HIGH, TG_1P5 and BG_1P5 Open			5.0	mA
S5 Mode Supply Current from 5VDUAL	I5VDL_S5	BUF_Cut = LOW, TG_1P5 and BG_1P5 Open			1.0	mA
S0 Mode Supply Current from BOOT	IBOOT_S0	BUF_Cut = LOW, BOOT = 12 V, TG_1P5 and BG_1P5 Open			20	mA
S3 Mode Supply Current from BOOT	IBOOT_S3	BUF_Cut = HIGH, TG_1P5 and BG_1P5 Open			20	mA

UNDER-VOLTAGE-MONITOR

5VDUAL UVLO Upper Threshold	V5VDLUV+				4.4	V
5VDUAL UVLO Hysteresis	V5VDLhys		250	400	550	mV
BOOT UVLO Upper Threshold	VBOOTUV+				10.4	V
BOOT UVLO Hysteresis	VBOOThys			1.0		V

THERMAL SHUTDOWN

Thermal Shutdown	Tsd	(Note 3)		145		$^\circ\text{C}$
Thermal Shutdown Hysteresis	Tsdhys	(Note 3)		25		$^\circ\text{C}$

DDQ SWITCHING REGULATOR

FBDDQ Feedback Voltage, Control Loop in Regulation	VF BQ	$T_A = 25^\circ\text{C}$ $T_A = 0^\circ\text{C}$ to 70°C	1.178 1.166	1.190	1.202 1.214	V
Feedback Input Current	IDDQFB	$V(\text{FBDDQ}) = 1.3\ \text{V}$			1.0	μA
Oscillator Frequency in S0 Mode	FDDQS0		217	250	283	KHz
Oscillator Frequency in S3 Mode	FDDQS3		434	500	566	KHz
Oscillator Ramp Amplitude	dVOSC	(Note 3)		1.3		Vp-p
Current Limit Blanking Time in S0 Mode	TDDQbk	(Note 3)	400			nS
Current Limit Threshold Offset from 5VDUAL	VOCP	(Note 3)	0.8			V
Minimum Duty Cycle	Dmin		0			%
Maximum Duty Cycle	Dmax				100	%
Soft-Start Pin Current for DDQ	Iss1	$V(\text{SS}) = 0\ \text{V}$		4.0		μA

DDQ ERROR AMPLIFIER

DC Gain	GAINDDQ	(Note 3)		70		dB
Gain-Bandwidth Product	GBWDDQ	COMP PIN to GND = 220 nF, 1.0 Ω in Series (Note 3)		12		MHz
Slew Rate	SRDDQ	COMP PIN TO GND = 10 pF		8.0		V/ μS

3. Guaranteed by design, not tested in production.

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ELECTRICAL CHARACTERISTICS (5VDUAL = 5 V, BOOT = 12 V, 5VATX = 5 V, DDQ_REF = 2.5 V, $T_A = 0^\circ\text{C}$ to 70°C , $L = 1.7\ \mu\text{H}$, $\text{COUT1} = 3770\ \mu\text{F}$, $\text{COUT2} = 470\ \mu\text{F}$, $\text{COUT3} = \text{NA}$, $\text{CSS} = 33\ \text{nF}$, $\text{R1} = 2.166\ \text{k}\Omega$, $\text{R2} = 2\ \text{k}\Omega$, $\text{RZ1} = 20\ \text{k}\Omega$, $\text{RZ2} = 8\ \Omega$, $\text{CP1} = 10\ \text{nF}$, $\text{CZ1} = 6.8\ \text{nF}$, $\text{CZ2} = 100\ \text{nF}$, $\text{RM1} = 2.166\ \text{k}\Omega$, $\text{RM2} = 2\ \text{k}\Omega$, $\text{RZM1} = 20\ \text{k}\Omega$, $\text{RZM2} = 8\ \Omega$, $\text{CPM1} = 10\ \text{nF}$, $\text{CZM1} = 6.8\ \text{nF}$, $\text{CZM2} = 100\ \text{nF}$ for min/max values unless otherwise noted.) duplicate component values of MCH regulator from DDQ.

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
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VTT ACTIVE TERMINATION REGULATOR

VTT tracking DDQ_REF/2 at S0 mode	dVTTs0	$I_{\text{OUT}} = 0$ to $2.0\ \text{A}$ (Sink Current) $I_{\text{OUT}} = 0$ to $-2.0\ \text{A}$ (Source Current)	-30		30	mV
VTT Source Current Limit	ILIMVTSrc		2.0			A
VTT Sink Current Limit	ILIMVTSnk		2.0			A
DDQ_REF Input Resistance	DDQREF			50		k Ω

CONTROL SECTION

BUF_Cut Input Logic HIGH	Logic_H		2.0			V
BUF_Cut Input Logic LOW	Logic_L				0.8	V
BUF_Cut Input Current	Ilogic				1.0	μA

GATE DRIVERS

TGDDQ Gate Pull-HIGH Resistance	RH_TG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{TGDDQ}) = 11.9\ \text{V}$		3.0		Ω
TGDDQ Gate Pull-LOW Resistance	RL_TG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{TGDDQ}) = 0.1\ \text{V}$		2.5		Ω
BGDDQ Gate Pull-HIGH Resistance	RH_BG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{BGDDQ}) = 11.9\ \text{V}$		3.0		Ω
BGDDQ Gate Pull-LOW Resistance	RL_BG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{BGDDQ}) = 0.1\ \text{V}$		1.3		Ω
TG1P5 Gate Pull-HIGH Resistance	RH_TPG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{TG1P5}) = 11.9\ \text{V}$		3.0		Ω
TG1P5 Gate Pull-LOW Resistance	RL_TPG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{TG1P5}) = 0.1\ \text{V}$		2.5		Ω
BG1P5 Gate Pull-HIGH Resistance	RH_BPG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{BG1P5}) = 11.9\ \text{V}$		3.0		Ω
BG1P5 Gate Pull-LOW Resistance	RL_BPG	$V_{\text{CC}} = 12\ \text{V}$, $V(\text{BG1P5}) = 0.1\ \text{V}$		1.3		Ω

MCH SWITCHING REGULATOR

VFB1P5 Feedback Voltage, Control Loop in Regulation	VFB1P5	$T_A = 0^\circ\text{C}$ to 70°C	0.784	0.8	0.816	V
Feedback Input Current	I1P5FB				1.0	μA
Oscillator Frequency	F1P5		217	250	283	KHz
Oscillator Ramp Amplitude	dV1P5OSC	(Note 4)		1.3		V _{p-p}
Minimum Duty Cycle	Dmin_1P5		0			%
Maximum Duty Cycle	Dmax_1P5				100	%
Soft-Start Pin Current for V1P5 regulator	ISS2	(Note 4)		8.0		μA

4. Guaranteed by design, not tested in production.

TYPICAL OPERATING CHARACTERISTICS

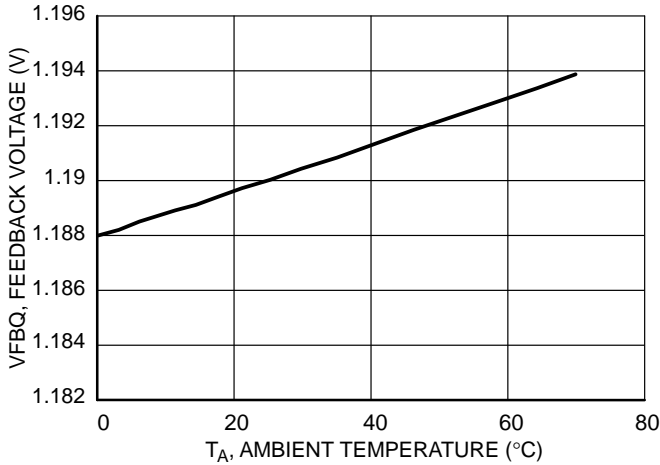


Figure 3. VFBQ Feedback Voltage vs. Ambient Temperature

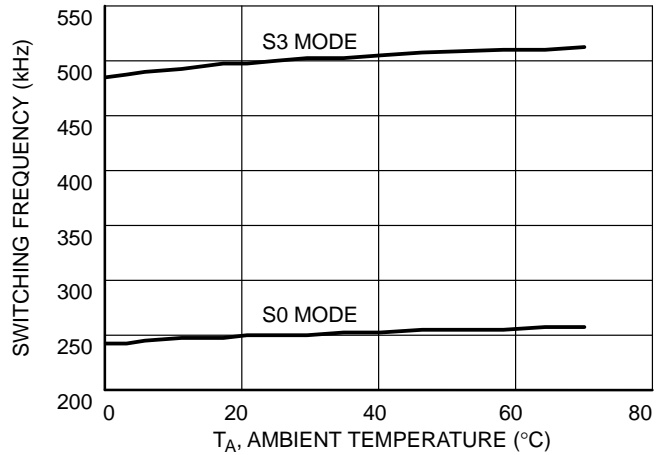


Figure 4. Oscillation Frequency in S0/S3 vs. Ambient Temperature

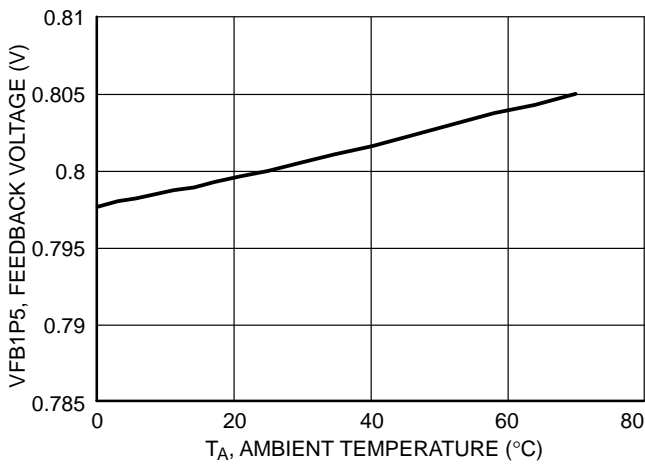


Figure 5. VFB1P5 Feedback Voltage vs. Ambient Temperature

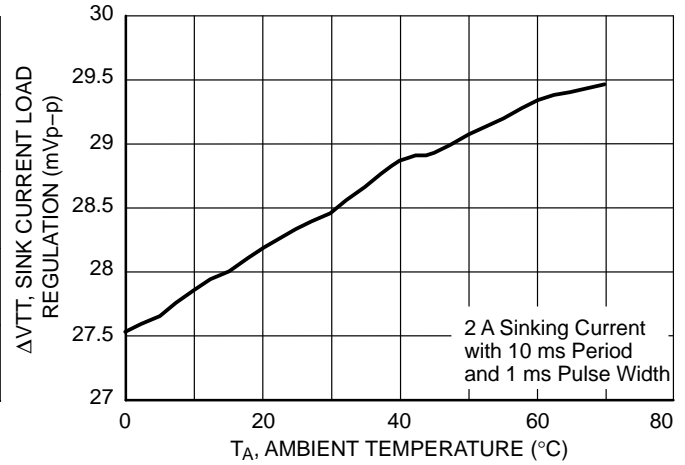


Figure 6. VTT Sink Current Load Regulation vs. Ambient Temperature

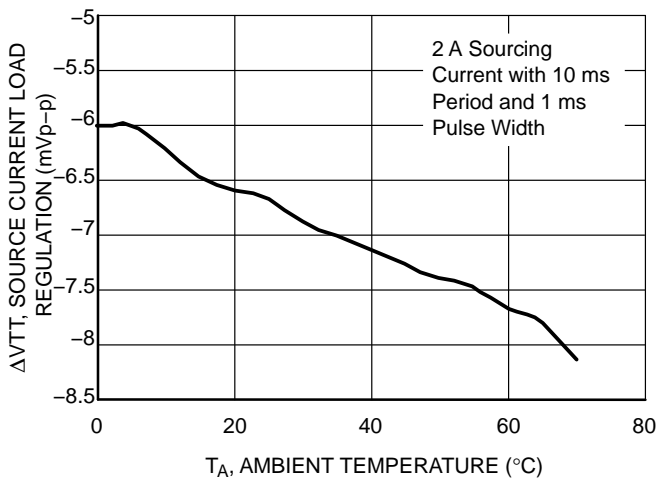


Figure 7. VTT Source Current Load Regulation vs. Ambient Temperature

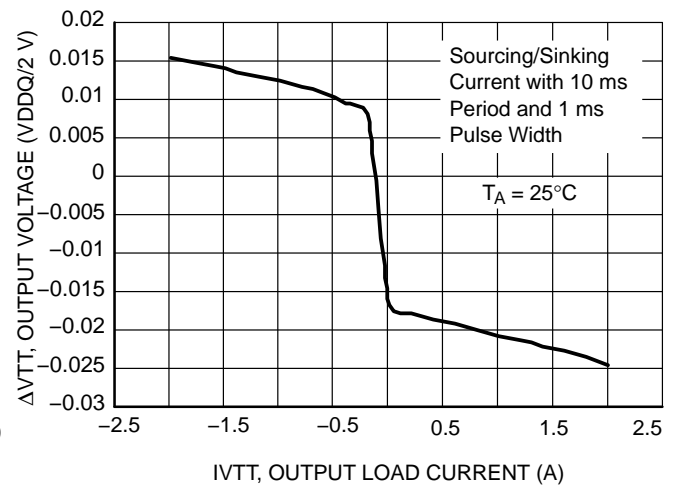
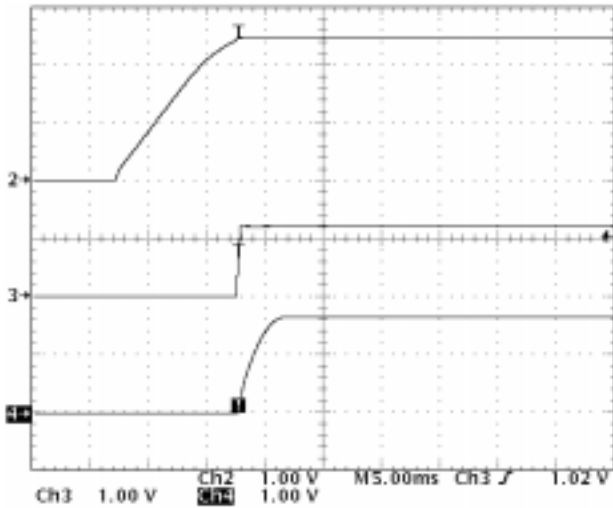


Figure 8. VTT Output Voltage vs. Load Current

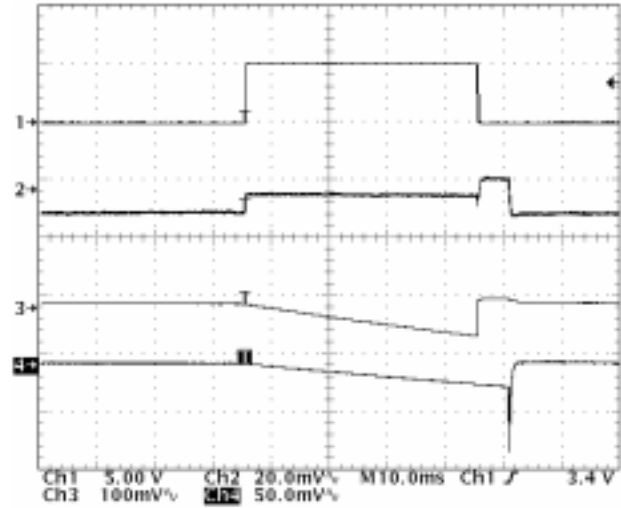
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TYPICAL OPERATING WAVEFORMS



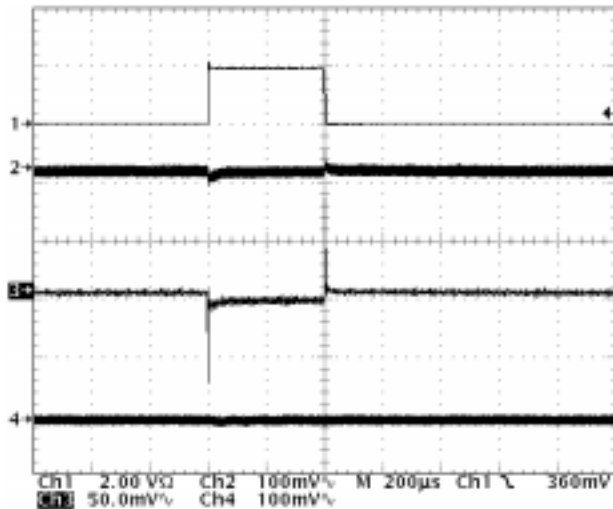
Channel 2: VDDQ Output Voltage, 1.0 V/div
 Channel 3: VTT Output Voltage, 1.0 V/div
 Channel 4: V1P5 Output Voltage, 1.0 V/div
 Time Base: 5.0 ms/div

Figure 9. Power-Up Sequence



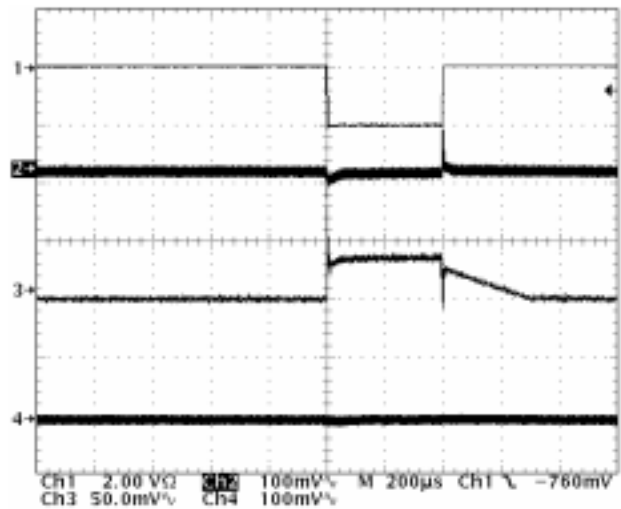
Channel 1: BUF_CUT Pin Voltage, 5.0 V/div
 Channel 2: VDDQ Output Voltage, AC-Coupled, 20 mV/div
 Channel 3: VTT Output Voltage, AC-Coupled, 100 mV/div
 Channel 4: V1P5 Output Voltage, AC-Coupled, 50 mV/div
 Time Base: 10 ms/div

Figure 10. S0-S3-S0 Transition



Channel 1: Current Sourced out of VTT, 2.0 A/div
 Channel 2: VDDQ Output Voltage, AC-Coupled, 100 mV/div
 Channel 3: VTT Output Voltage, AC-Coupled, 50 mV/div
 Channel 4: V1P5 Output Voltage, AC-Coupled, 100 mV/div
 Time Base: 200 μs/div

Figure 11. VTT Source Current Transient, 0A-2A-0A

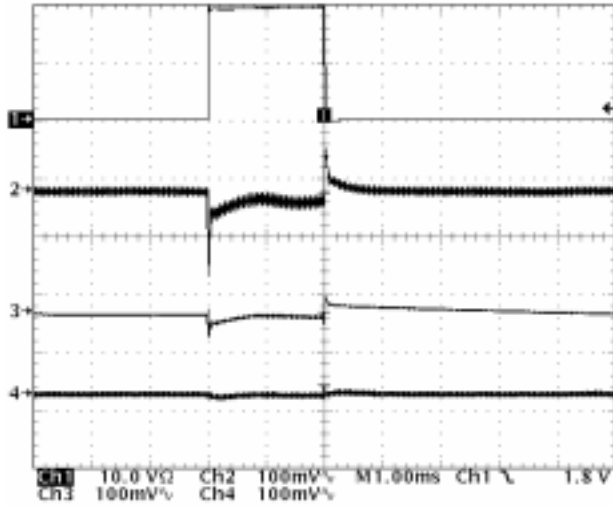


Channel 1: Current Sunk into of VTT, 2.0 A/div
 Channel 2: VDDQ Output Voltage, AC-Coupled, 100 mV/div
 Channel 3: VTT Output Voltage, AC-Coupled, 50 mV/div
 Channel 4: V1P5 Output Voltage, AC-Coupled, 100 mV/div
 Time Base: 200 μs/div

Figure 12. VTT Sink Current Transient, 0A-2A-0A

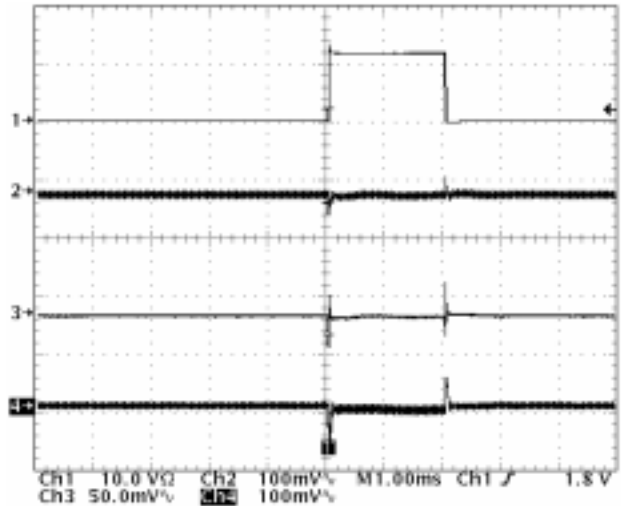
NCP5210

TYPICAL OPERATING WAVEFORMS



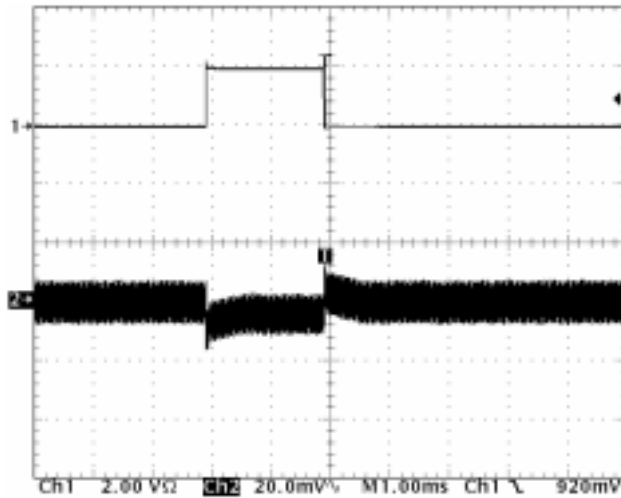
Channel 1: Current Sourced into of VDDQ, 10 A/div
 Channel 2: VDDQ Output Voltage, AC-Coupled, 100 mV/div
 Channel 3: VTT Output Voltage, AC-Coupled, 100 mV/div
 Channel 4: V1P5 Output Voltage, AC-Coupled, 100 mV/div
 Time Base: 1.0 ms/div

**Figure 13. VDDQ Source Current Transient,
 0A-20A-0A**



Channel 1: Current Sourced into of V1P5, 10 A/div
 Channel 2: VDDQ Output Voltage, AC-Coupled, 100 mV/div
 Channel 3: VTT Output Voltage, AC-Coupled, 50 mV/div
 Channel 4: V1P5 Output Voltage, AC-Coupled, 100 mV/div
 Time Base: 1.0 ms/div

**Figure 14. V1P5 Source Current Transient,
 0A-12A-0A**



Channel 1: Current Sourced into of VDDQ, 2.0 A/div
 Channel 2: VDDQ Output Voltage, AC-Coupled, 20 mV/div
 Time Base: 1.0 ms/div

Figure 15. S3 Mode without 12VATX, 0A-2A-0A

DETAILED OPERATION DESCRIPTIONS

General

The NCP5210 3–In–1 PWM Dual Buck Linear DDR Power Controller contains two high efficiency PWM controllers and an integrated two–quadrant linear regulator.

The VDDQ supply is produced by a PWM switching controller with two external N–Ch FETs. The VTT termination voltage is an integrated linear regulator with sourcing and sinking current capability which tracks at 1/2 VDDQ. The MCH core voltage is created by the secondary switching controller.

The inclusion of soft–start, supply undervoltage monitors, short circuit protection and thermal shutdown, makes this device a total power solution for the MCH and DDR memory system. This device is housed in a thermal enhanced space–saving QFN–20 package.

ACPI Control Logic

The ACPI control logic is powered by the 5VDUAL supply. External control is applied to the high impedance CMOS input labeled BUF_CUT. This signal and two internal under voltage detectors are used to determine the operating mode according to the state diagram in Figure 17.

These UVLOs monitor the external supplies, 5VDUAL and 12VATX, through 5VDUAL and BOOT pins respectively. Two control signals, _5VDUALGD and _BOOTGD, are asserted when the supply voltages are good.

The device is powered up initially in the S5 shutdown mode to minimize the power consumption. When all three supply voltages are good and BUF_CUT is LOW, the device enters the S0 normal operating mode. Transition of BUF_CUT from LOW to HIGH in S0 mode triggers the device into S3 sleep mode. In S3 mode 12VATX supply collapses. When BUF_CUT is deasserted the state will change back to S0 mode. The IC can re–enter S5 mode by removing one of the supplies during S0 mode. It should be noted that transitions from S3 to S5 or vice versa are not allowed. A timing diagram is shown in Figure 16.

Table 1 summarizes the operating states of all the regulators, as well as the conditions of output pins.

Internal Bandgap Voltage Reference

An internal bandgap reference is generated whenever 5VDUAL exceeds 2.7 V. Once this bandgap reference is in regulation, an internal signal _VREFGD is asserted.

Table 1. Mode, Operation and Output Pin Condition

MODE	OPERATING CONDITIONS			OUTPUT PIN CONDITIONS			
	DDQ	VTT	MCH	TGDDQ	BGDDQ	TP_1P5	BG_1P5
S0	Normal	Normal	Normal	Normal	Normal	Normal	Normal
S3	Standby	H–Z	OFF	Standby	Standby	Low	Low
S5	OFF	H–Z	OFF	Low	Low	Low	Low

S5–To–S0 Mode Power–Up Sequence

The ACPI control logic is enabled by the assertion of _VREFGD. Once the ACPI control is activated, the powerup sequence starts by waking up the 5VDUAL voltage monitor block. If the 5VDUAL supply is within the preset levels, the BOOT under voltage monitor block is then enabled. After 12VATX is ready and the BOOT UVLO is asserted LOW, the ACPI control triggers this device from S5 shutdown mode into S0 normal operating mode by activating the soft–start of DDQ switching regulator, providing BUF_CUT remaining LOW.

Once the DDQ regulator is in regulation and the soft–start interval is completed, the _INREGDDQ signal is asserted HIGH to enable the VTT regulator as well as the V1P5 switching regulator.

DDQ Switching Regulator

In S0 mode the DDQ regulator is a switching synchronous rectification buck controller driving two external power N–Ch FETs to supply up to 20 A. It employs voltage mode fixed frequency PWM control with external compensation switching at 250kHz \pm 13.2%. As shown in Figure 2, the VDDQ output voltage is divided down and fed back to the inverting input of an internal amplifier through the FBDDQ pin to close the loop at $VDDQ = VFBQ \times (1 + R1/R2)$. This amplifier compares the feedback voltage with an internal reference voltage of 1.190 V to generate an error signal for the PWM comparator. This error signal is compared with a fixed frequency RAMP waveform derived from the internal oscillator to generate a pulse–width–modulated signal. The PWM signal drives the external N–Ch FETs via the TG_DDQ and BG_DDQ pins. External inductor L and capacitor COUT1 filter the output waveform. When the IC leaves the S5 state, the VDDQ output voltage ramps up at a soft–start rate controlled by the capacitor at the SS pin. When the regulation of VDDQ is detected in S0 mode, _INREGDDQ goes HIGH to notify the control block.

In S3 standby mode, the switching frequency is doubled to reduce the conduction loss in the external N–Ch FETs.

For enhanced efficiency, an active synchronous switch is used to eliminate the conduction loss contributed by the forward voltage of a diode or Schottky diode rectifier. Adaptive non-overlap timing control of the complementary gate drive output signals is provided to reduce shoot-through current that degrades efficiency.

Tolerance of VDDQ

Both the tolerance of VFBQ and the ratio of the external resistor divider R1/R2 impact the precision of VDDQ. With the control loop in regulation, $VDDQ = VFBQ \times (1 + R1/R2)$. With a worst case (for all valid operating conditions) VFBQ tolerance of $\pm 1.5\%$, a worst case range of $\pm 2\%$ for VDDQ will be assured if the ratio R1/R2 is specified as $1.100 \pm 1\%$.

Fault Protection of VDDQ Regulator

In S0 mode, an internal voltage (VOCP) = $5VDUAL - 0.8$ sets the current limit for the high-side switch. The voltage VOCP pin is compared to the voltage at SWDDQ pin when the high-side gate drive is turned on after a fixed period of blanking time to avoid false current limit triggering. When the voltage at SWDDQ is lower than VOCP, an overcurrent condition occurs and all regulators are latched off to protect against overcurrent. The IC can be powered up again if one of the supply voltages, 5VDUAL or 12VATX, is recycled. The main purpose is for fault protection but not to be for an precise current limit.

In S3 mode, this overcurrent protection feature is disabled.

Feedback Compensation of VDDQ Regulator

The compensation network is shown in Figure 2.

VTT Active Terminator

The VTT active terminator is a 2 quadrant linear regulator with two internal N-Ch FETs to provide current sink and source capability up to 2.0 A. It is activated only when the DDQ regulator is in regulation in S0 mode. It draws power from VDDQ with the internal gate drive power derived from 5VDUAL. While VTT output is connecting to the FBVTT pin directly, VTT voltage is designed to automatically track

at the half of DDQ_REF. This regulator is stable with any value of output capacitor greater than 470 μ F, and is insensitive to ESR ranging from 1-m Ω to 400 m Ω .

Fault Protection of VTT Active Terminator

To provide protection for the internal FETs, bi-directional current limit preset at 2.4 A magnitude is implemented. The VTT current limit provides a soft-start function during startup.

MCH Switching Regulator

The secondary switching regulator is identical to the DDQ regulator except the output is 10 A, no fault protection is implemented and the soft-start timing is twice as fast with respect to CSS.

BOOT Pin Supply Voltage

In typical application, a flying capacitor is connected between SWDDQ and BOOT pins. In S0 mode, 12VATX is tied to BOOT pin through a Schottky diode as well. A 13-V Zener clamp circuit must clamp this boot strapping voltage produced by the flying capacitor in S0 mode.

In S3 mode the 12VATX is collapsed and the BOOT voltage is created by the Schottky diode between 5VDUAL and BOOT pins as well as the flying capacitor. The BOOT_UVLO works specially. The _BOOTGD goes low and the IC remains in S3 mode.

Thermal Consideration

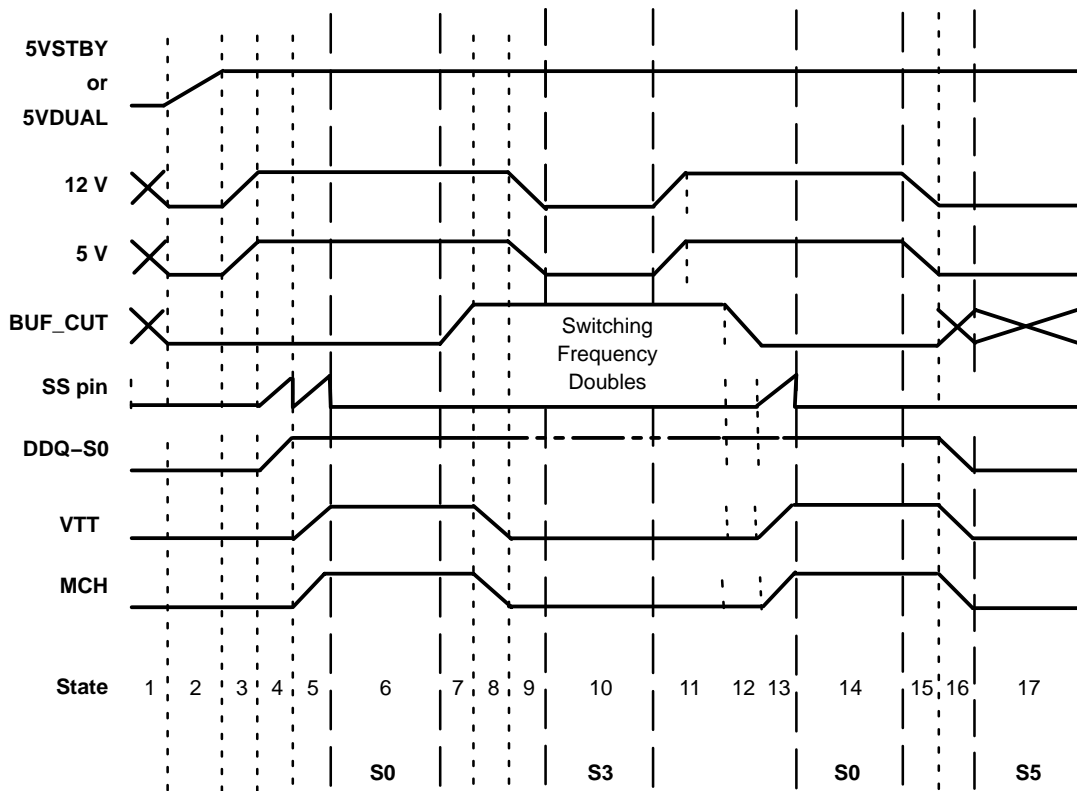
Assuming an ambient temperature of 50°C, the maximum allowed dissipated power of QFN-20 is 2.8 W, which is enough to handle the internal power dissipation in S0 mode.

To take full advantage of the thermal capability of this package, the exposed pad underneath must be soldered directly onto a PCB metal substrate to allow good thermal contact.

Thermal Shutdown

When the chip junction temperature exceeds 145°C, the entire IC is shutdown, until the junction temperature drops below 120°C. Below which, the chip resumes normal operation.

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2. 5VSTBY or 5VSTB is the Ultimate Chip Enable. This supply has to be up first to ensure gates are in known state.
3. 12 V and 5 V supplies can ramp in either order.
4. DDQ will ramp with the tracking of SS pin, timing is $1.2 * C_{SS} / 4 \mu$ (sec).
5. DDQ SS is completed, then SS pin is released from DDQ. SS pin is shorted to ground.
6. MCH ramps with the tracking of SS pin ramp, timing is $0.8 * C_{SS} / 8 \mu$ (sec). VTT rises.
6. MCH SS is completed, then SS pin is released from MCH. SS pin is shorted to ground. S0 Mode.
7. S3 MODE – BUF_CUT = H.
8. VTT and MCH will be turned off.
9. 12 V and 5 V ramps to 0 V.
10. Standard S3 Mode.
11. 12 V and 5 V ramp back to regulation.
12. BUF_CUT goes LOW.
13. 12 V UVLO = L and BUF_CUT = L. MCH ramps with SS pin, timing is $0.8 * C_{SS} / 8 \mu$ (sec). VTT rises.
14. S0 Mode.
15. Prepare S5 Mode – BUF_CUT = L, and 12VUVLO = H or 5VUVLO = H.
16. DDQ, VTT, and MCH Turned OFF.
17. S5 Mode.

Figure 16. NCP5210 Timing Diagram

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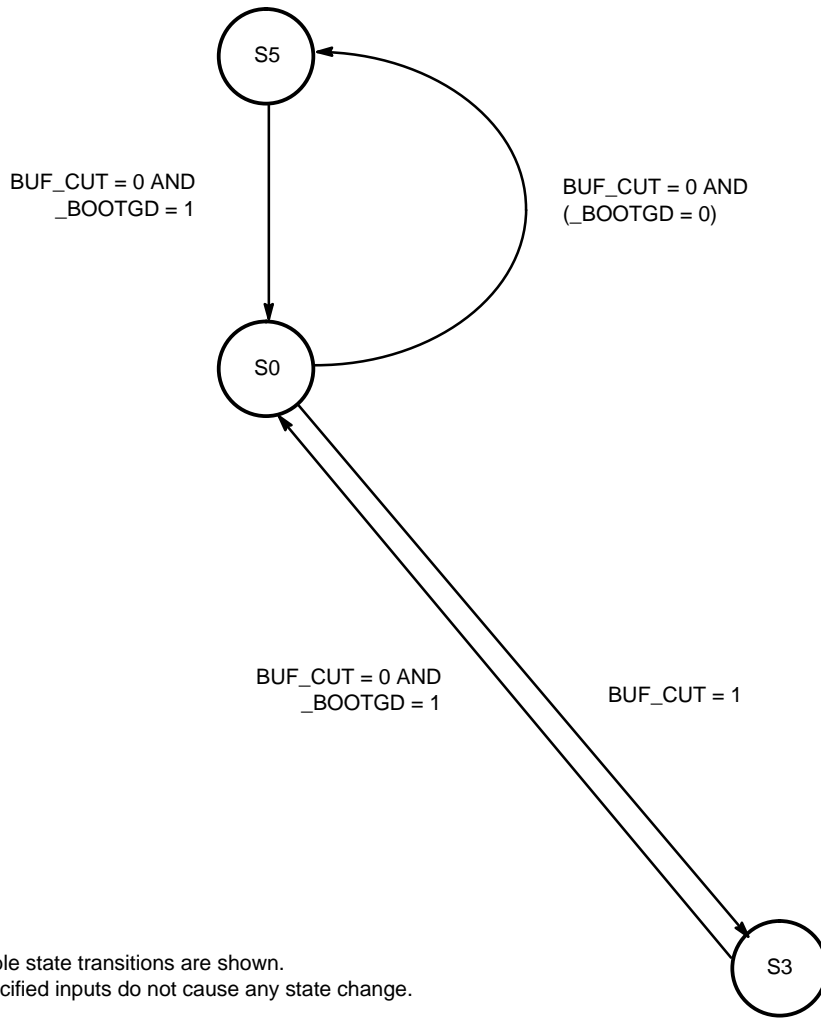


Figure 17. State Transitions Diagram of NCP5210

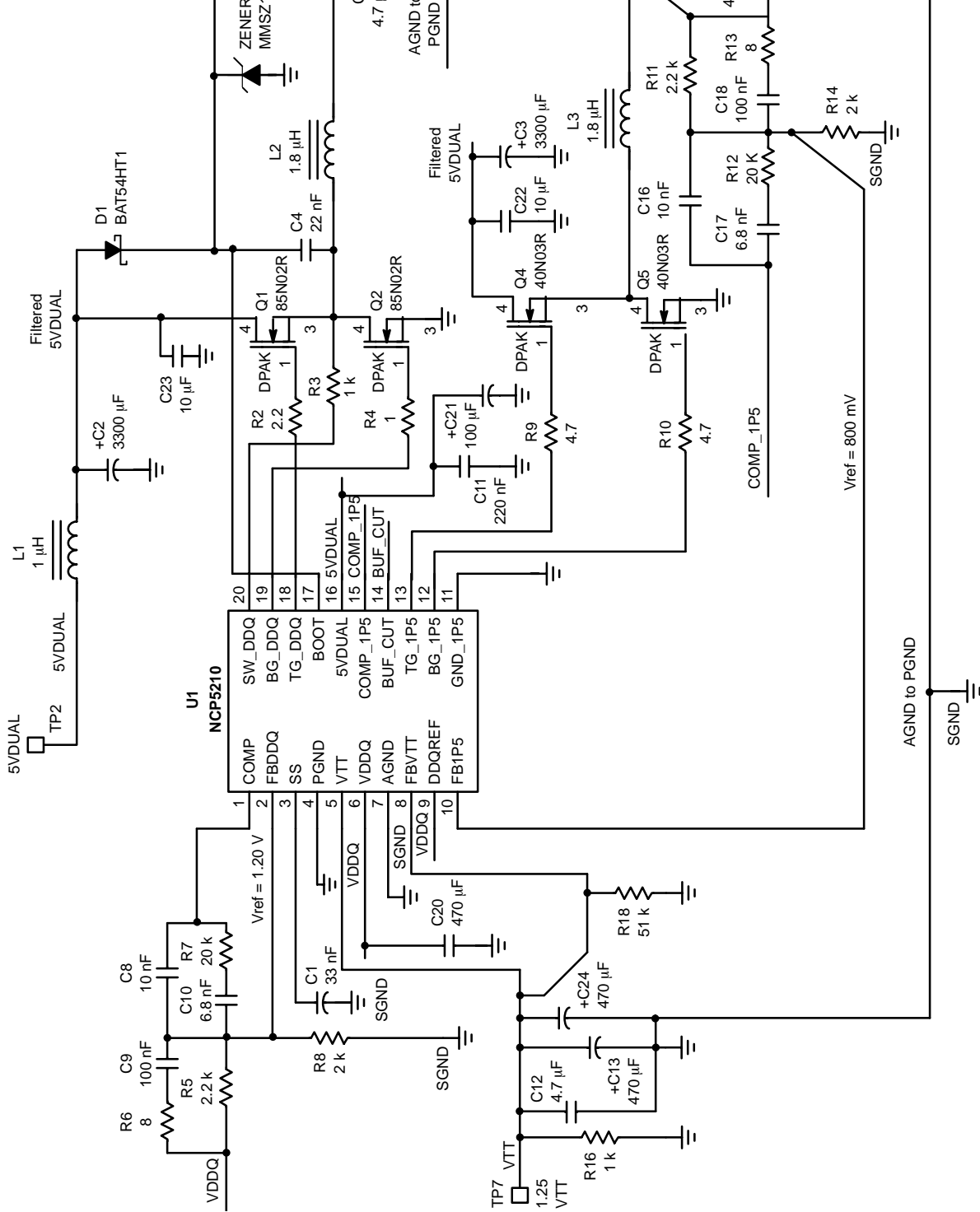


Figure 18. NCP5210 Typical Application Circuit

Application Circuit

Figure 18 shows the typical application circuit for NCP5210. The NCP5210 is specifically designed as a total power solution for the MCH and DDR memory system. This diagram contains NCP5210 for driving four external N-Ch FETs to form the DDR memory supply voltage (VDDQ) and the MCH regulator.

Output Inductor Selection

The value of the output inductor is chosen by balancing ripple current with transient response capability. A value of 1.7 μH will yield about 3.0 A peak-to-peak ripple current when converting from 5.0 V to 2.5 V at 250 kHz. It is important that the rated inductor current is not exceeded during full load, and that the saturation current is not less than the expected peak current. Low ESR inductors may be required to minimize DC losses and temperature rises.

Input Capacitor Selection

Input capacitors for PWM power supplies are required to provide a stable, low impedance source node for the buck regulator to convert from. The usual practice is to use a combination of electrolytic capacitors and multi-layer ceramic capacitors to provide bulk capacitance and high frequency noise suppression. It is important that the capacitors are rated to handle the AC ripple current at the input of the buck regulators, as well as the input voltage. In the NCP5210 the DDQ and MCH regulators are interleaved (out of phase by 180°) to reduce the peak AC input current.

Output Capacitor Selection

Output capacitors are chosen by balancing the cost with the requirements for low output ripple voltage and transient voltage. Low ESR electrolytic capacitors can be effective at reducing ripple voltage at 250 kHz. Low ESR ceramic capacitors are most effective at reducing output voltage excursions caused by fast load steps of system memory and the memory controller.

Power MOSFET Selection

Power MOSFETs are chosen by balancing the cost with the requirements for the current load of the memory system and the efficiency of the converter provided. The selections criteria can be based on the drain-to-source voltage, drain-to-current, on-resistance $R_{DS(on)}$, and input gate capacitance. Low $R_{DS(on)}$ and high drain-to-current power MOSFETs are usually preferred to achieve the high current requirement of the DDR memory system and MCH, as well as the high efficiency of the converter. The tradeoff is a corresponding increase in the input gate capacitor of the power MOSFETs.

PCB Layout Consideration

With careful PCB layout the NCP5210 can supply 20 A or more current. It is very important to use wide traces or large copper shades to carry current from the input node through the MOSFET switches, inductor, and to the output filters and load. Reducing the length of high current nodes will reduce losses and reduce parasitic inductance. It is usually best to locate the input capacitors, the MOSFET switches, and the output inductor in close proximity to reduce DC losses, parasitic inductance and radiated EMI.

The sensitive voltage feedback and compensation networks should be placed near NCP5210 and away from the switch nodes and other noisy circuit elements. Placing compensation components near each other will minimize the loop area and further reduce noise susceptibility.

Optional Boost Voltage Configuration

The charge pump circuit in Figure 19 can be used instead of boost voltage scheme of Figure 18. The advantage in Figure 19 is the elimination of the requirement for the Zener clamp. The tradeoff is slightly less boost voltage and a corresponding increase in MOSFET conduction losses.

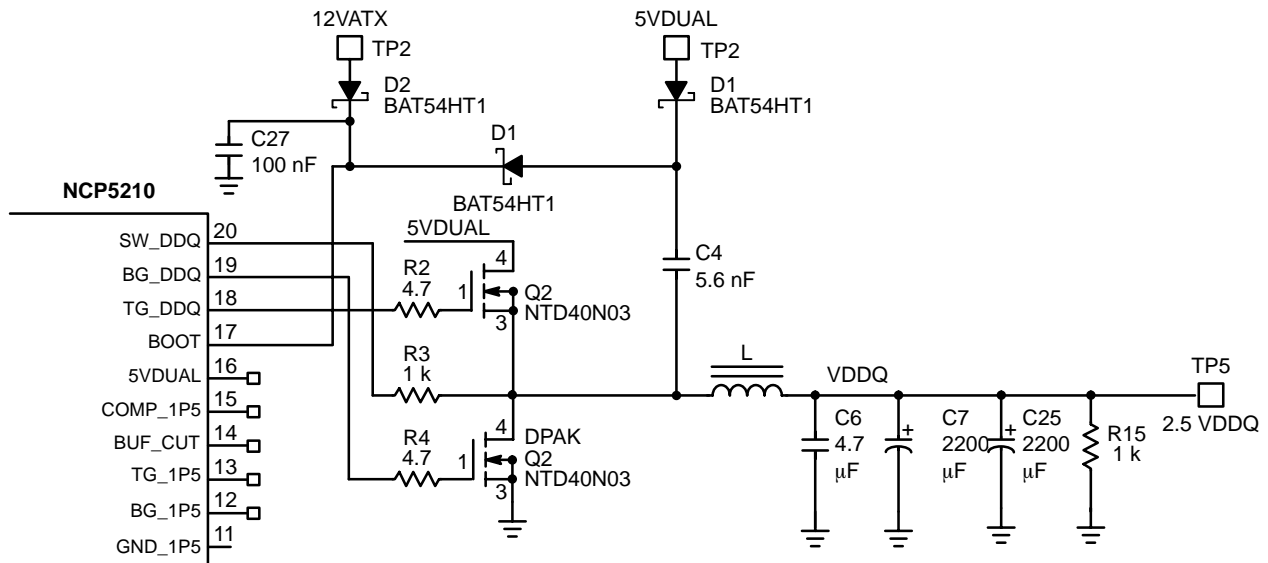


Figure 19. Charge Pump Circuit at BOOT Pin

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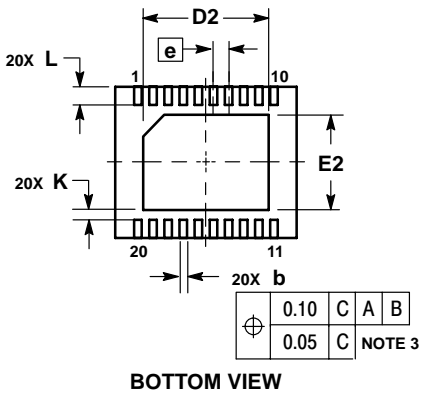
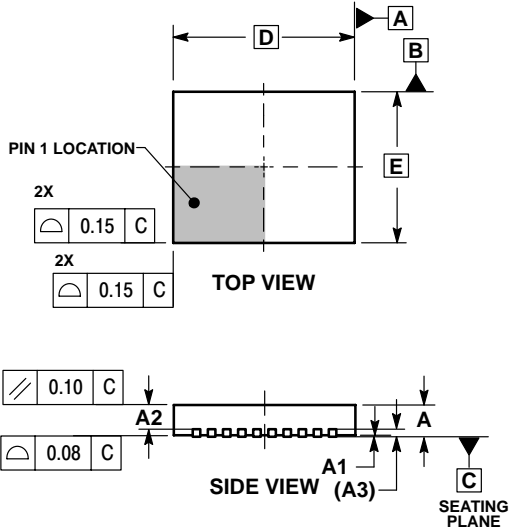
Table 2. Bill of Material of NCP5210 Application Circuit

Ref Design	Description	Value	Qty	Part #	Manufacturer
Q1, Q2	Power MOSFET N-Channel	24 V, 4.8 mΩ, 85 A	2	NTD85N02R	ON Semiconductor
Q3, Q4	Power MOSFET N-Channel	25 V, 12.6 mΩ, 40 A	2	NTD40N03R	ON Semiconductor
D1, D2	Rectifier Schottky Diode	30 V	2	BAT54HT1	ON Semiconductor
U1	Controller	3-in-1 PWM Dual Buck and Linear Power Controller	1	NCP5210	ON Semiconductor
Zener	Zener Diode	13 V, 0.5 W	1	MMSZ13T1	ON Semiconductor
L1	Toroidal Choke	1.0 μH, 25 A	1	T60-26(6T)	-
L2, L3	Toroidal Choke	1.8 μH, 25 A	2	T50-26B(6T)	-
C2, C3	Aluminum Electrolytic Capacitor	3300 μF, 6.3 V	2	EEUFJ0J332U	Panasonic
C5	Aluminum Electrolytic Capacitor	470 μF, 35 V	1	EEUFC1V471	Panasonic
C21	Aluminum Electrolytic Capacitor	100 μF, 50 V	1	EEUFC1H101	Panasonic
C20	Aluminum Electrolytic Capacitor	470 μF, 16 V	1	EEUFC1C471	Panasonic
C13, C24	Aluminum Electrolytic Capacitor	470 μF, 10 V	2	EEUFC1A471	Panasonic
C7, C25, C15, C26	Aluminum Electrolytic Capacitor	2200 μF, 6.3 V	4	EEUFC0J222SL	Panasonic
C11	Ceramic Capacitor	220 nF, 10 V	1	ECJ1VB1A224K	Panasonic
C6, C12, C14	Ceramic Capacitor	4.7 μF, 6.3 V	3	ECJHVB0J475M	Panasonic
C22, C23	Ceramic Capacitor	10 μF, 25 V	2	ECJ4YB1E106M	Panasonic
C4	Ceramic Capacitor	22 nF, 25 V	1	ECJ1VB1E223K	Panasonic
C10, C17	Ceramic Capacitor	6.8 nF, 50 V	2	ECJ1VB1H682K	Panasonic
C9, C18	Ceramic Capacitor	100 nF, 16 V	2	ECJ1VB1C104K	Panasonic
C8, C16	Ceramic Capacitor	10 nF, 50 V	2	ECJ1VB1H103K	Panasonic
C1	Ceramic Capacitor	33 nF, 25 V	1	ECJ1VB1E333K	Panasonic
R2	Resistor	2.2 Ω	1	-	-
R4	Resistor	1.0 Ω	1	-	-
R9, R10	Resistor	4.7 Ω	2	-	-
R3, R15, R16, R17	Resistor	1.0 kΩ	4	-	-
R7, R12	Resistor	20 kΩ	2	-	-
R6, R13	Resistor	8.2 Ω	2	-	-
R8, R14	Resistor	2.0 kΩ	2	-	-
R5, R11	Resistor	2.2 kΩ	2	-	-
R18	Resistor	51 kΩ	1	-	-

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PACKAGE DIMENSIONS

QFN-20, DUAL-SIDED, 6x5 mm
 MN SUFFIX
 CASE 505AB-01
 ISSUE A




NOTES:

1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
2. DIMENSIONS IN MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINALS AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

DIM	MILLIMETERS	
	MIN	MAX
A	0.80	1.00
A1	0.00	0.05
A2	0.65	0.75
A3	0.20	REF
b	0.23	0.28
D	6.00	BSC
D2	3.98	4.28
E	5.00	BSC
E2	2.98	3.28
e	0.50	BSC
K	0.20	---
L	0.50	0.60

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